

# CERTIFICATE OF ANALYSIS

**31X MNB12 (batch B)**

## Certified Reference Material Information

Type: MANGANESE BRASS (CHILL CAST)  
Form and Size: Disc ~40mm diameter  
Manufactured by: Polycast Ltd  
Certified and Supplied by: MBH Analytical Ltd

## Assigned Values

### Percentage element by weight

Element	Sn	Pb	Zn	Fe	Mn	Ni	Al	Si	Cr
Value <sup>1</sup>	0.194	1.96	21.76	0.313	18.37	0.497	0.70	0.0487	0.0013
Uncertainty <sup>2</sup>	0.002	0.02	0.06	0.002	0.08	0.005	0.02	0.0012	0.0003

Element	Co	As	Bi	Sb	Cd	P	S	C	Cu
Value <sup>1</sup>	0.0040	0.0077	0.0204	0.0072	0.0014	0.0521	(0.0006)	0.0125	56.03
Uncertainty <sup>2</sup>	0.0002	0.0005	0.0013	0.0007	0.0001	0.0017	-	0.0010	0.09

Note: values given in parentheses are not certified - they are provided for information only.

## Definitions

- <sup>1</sup> The certified values are the present best estimates of the true content for each element. Each value is a panel consensus, based on the averaged results of an interlaboratory testing programme, detailed on page 3.
- <sup>2</sup> The uncertainty values are generated from the 95% confidence interval derived from the wet analysis results, in combination with a statistical assessment of the homogeneity data, as described on page 2.

## Certified by:

MBH ANALYTICAL LIMITED \_\_\_\_\_

on 22nd May 2013

C Eveleigh

## **Method of Preparation**

This reference material was produced from commercial-grade brass, binaries and master alloys. The discs are the product of one melt poured into a sequence of multiple chill moulds with feeding systems designed to ensure sound discs. Approximately 2mm has been removed from the cast faces of the discs to minimise surface effects.

## **Sampling**

Samples for chemical analysis were taken from various positions throughout the casting process. At least 15% of all discs were selected for non-destructive homogeneity testing.

## **Homogeneity**

The discs were checked for sample and batch uniformity using an optical emission spectrometer. Using the meaned data from each surface, standard deviation values were derived for each element as an indicator of any non-homogeneity (as determined for the specific sample size taken by the spectrometer).

## **Chemical Analysis**

Analysis was carried out on millings taken from samples representative of the product. It was performed by a panel of laboratories mostly operating within the terms of EN ISO/IEC 17025 - 2005, using documented standard reference methods and validated by appropriate reference materials. The individual values listed overpage are the average of each analyst's results.

## **Estimation of Uncertainties**

Each element certified has been analysed by several laboratories, and 95% half-width confidence intervals ( $C_{(95\%)}$ ) for the resultant mean values have been derived by the method shown on page 3.

As a separate exercise, the degree of non-homogeneity of the batch for each element has been quantified by a programme of non-destructive application testing, discussed above.

The final certified uncertainty for each element has been derived by combining these two factors, using the square-root of the summed squares.

## **Traceability**

Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials. In addition, some of the results derived as part of this testing programme have traceability to NIST standards, as part of the analytical calibration or process control.

## **Usage**

Intended use: With optical emission and X-ray fluorescence spectrometers.

Recommended method of use: Copper alloys are generally prepared by machining on a mill or a lathe. However, users are recommended to follow the calibration and sample preparation procedures specified by the relevant instrument manufacturer.

Preparation should be the same for reference materials and the samples for test.

A minimum of five consistent replicate analyses is recommended to provide the necessary sample size. Users are advised to check against possible bias between reference materials and production samples due to differences in metallurgical history, and be aware of possible inter-element effects.

## Analytical Data

### Percentage element by weight

Sample	Sn	Pb	Zn	Fe	Mn	Ni	Al	Si	Cr
1	0.188	1.924	21.64	0.309	18.21	0.485	0.666	0.0466	0.0007
2	0.190	1.931	21.69	0.310	18.23	0.487	0.671	0.0469	0.0007
3	0.191	1.940	21.69	0.310	18.25	0.493	0.675	0.0470	0.0009
4	0.191	1.943	21.75	0.312	18.27	0.493	0.680	0.0475	0.0011
5	0.193	1.946	21.75	0.312	18.29	0.494	0.692	0.0481	0.0011
6	0.194	1.947	21.76	0.313	18.30	0.494	0.698	0.0484	0.0013
7	0.194	1.949	21.78	0.313	18.38	0.496	0.703	0.0489	0.0013
8	0.195	1.961	21.79	0.313	18.38	0.499	0.714	0.0489	0.0014
9	0.196	1.980	21.83	0.315	18.47	0.500	0.718	0.0505	0.0014
10	0.197	1.990	21.88	0.318	18.49	0.500	0.722	0.0515	0.0017
11	0.199	1.999			18.51	0.502	0.725	0.0519	0.0018
12	0.201	2.012			18.51	0.506	0.730		0.0018
13		2.016			18.51	0.506	0.731		0.0020
14						0.507	0.735		
<b>Mean</b>	<b>0.194</b>	<b>1.960</b>	<b>21.76</b>	<b>0.313</b>	<b>18.37</b>	<b>0.497</b>	<b>0.704</b>	<b>0.0487</b>	<b>0.0013</b>
<b>Std Dev</b>	0.004	0.028	0.07	0.003	0.12	0.007	0.024	0.0018	0.0004
<b>C<sub>(95%)</sub></b>	0.002	0.017	0.05	0.002	0.07	0.004	0.014	0.0012	0.0003

Sample	Co	As	Bi	Sb	Cd	P	S	C	Cu
1	0.0035	0.0064	0.0177	0.0050	0.0011	0.0468	0.0001	0.0106	55.86
2	0.0036	0.0067	0.0177	0.0051	0.0012	0.0492	0.0005	0.0115	55.87
3	0.0036	0.0068	0.0180	0.0061	0.0013	0.0499	0.0005	0.0120	55.95
4	0.0037	0.0069	0.0182	0.0067	0.0013	0.0500	0.0006	0.0124	56.00
5	0.0038	0.0070	0.0186	0.0068	0.0013	0.0508	0.0008	0.0127	56.02
6	0.0039	0.0071	0.0197	0.0070	0.0013	0.0516	0.0009	0.0129	56.06
7	0.0039	0.0075	0.0202	0.0071	0.0014	0.0522	0.0011	0.0130	56.09
8	0.0040	0.0078	0.0218	0.0072	0.0014	0.0525	<0.001	0.0148	56.10
9	0.0040	0.0081	0.0222	0.0074	0.0014	0.0536	<0.003		56.15
10	0.0041	0.0082	0.0224	0.0076	0.0014	0.0537	<0.003		56.18
11	0.0042	0.0082	0.0225	0.0080	0.0014	0.0548			
12	0.0042	0.0083	0.0226	0.0086	0.0015	0.0554			
13	0.0043	0.0084	0.0232	0.0086	0.0016	0.0569			
14	0.0045	0.0088		0.0090	0.0016				
15	0.0048	0.0090							
<b>Mean</b>	<b>0.0040</b>	<b>0.0077</b>	<b>0.0204</b>	<b>0.0072</b>	<b>0.0014</b>	<b>0.0521</b>	<b>0.0006</b>	<b>0.0125</b>	<b>56.03</b>
<b>Std Dev</b>	0.0004	0.0008	0.0021	0.0012	0.0001	0.0028	0.0003	0.0012	0.11
<b>C<sub>(95%)</sub></b>	0.0002	0.0005	0.0013	0.0007	0.0001	0.0017	0.0003	0.0010	0.08

Note: C<sub>(95%)</sub> is the 95% half-width confidence interval derived from the equation:

$$C_{(95\%)} = (t \times SD) / \sqrt{n}$$

where n is the number of available values, t is the Student's t value for n-1 degrees of freedom, and SD is the standard deviation of the test results.

## Participating Laboratories

Exova Ltd  
Sheffield Assay Office  
Universal Scientific Laboratory Pty Ltd  
Genitest, Inc  
Institute of Iron & Steel Technology  
Luo Yang Copper  
Sargam Metals Pvt Ltd  
Raghavendra Spectromet Laboratory  
TCR Engineering Services Ltd  
Institute of Non-Ferrous Metals  
Colonial Metals Co  
De Bruyn Spectroscopic Solutions Ltd  
Coleshill Laboratories Ltd  
London & Scandinavian Met Co  
Lithea sro

Middlesbrough, England  
Sheffield, England  
Milperra, NSW, Australia  
Montreal, Canada  
Shanghai, China  
Luo Yang, He Nan, China  
Chennai, India  
Bangalore, India  
Mumbai, India  
Gliwice, Poland  
Columbia, PA, USA  
Johannesburg, South Africa  
Birmingham, England  
Rotherham, England  
Brno, Czech Republic

UKAS accreditation 0239  
UKAS accreditation 0012  
NATA accreditation 0492  
PRI accreditation 123077  
CNAL accreditation 0783  
CNAL accreditation 0173  
NABL accreditation 0025  
NABL accreditation 0371  
NABL accreditation 0367  
PCA accreditation AB274

Note: to achieve the above accreditation (eg UKAS, NATA, etc), test houses must demonstrate conformity to the general requirements of EN ISO/IEC 17025.

## Analytical Methods Used

ELEMENT	RESULT No. & METHOD			
	ICP-AES	FAAS		OTHER
Tin	1, 3, 4, 6-8, 10, 11	2, 5, 12	9	photometric (phenyl fluorone)
Lead	1, 4-11, 13	2, 3	12	electrogravimetric
Zinc	5, 6, 8-10	-	1	XRF
			2-4, 7	volumetric (EDTA)
Iron	1, 3, 4, 7, 8, 10	2, 5, 6, 9		
Manganese	2-4, 8, 11-13	6	1, 5, 7, 10	volumetric (FAS, arsenite)
			9	XRF
Nickel	1-4, 6, 11, 12, 14	5, 7-10	13	photometric (dimethyl glyoxime)
Aluminium	1-5, 7, 10, 11, 14	6, 8, 13	9, 12	photometric (chrome azurol S)
Silicon	1, 4, 5, 7, 8, 10, 11	-	2, 3, 6	photometric (molybdenum blue)
			9	gravimetric (perchloric acid)
Chromium	1-3, 5, 8-12	4, 6, 7, 13		
Cobalt	3-9, 11, 12, 14, 15	1, 2, 10, 13		
Arsenic	1-7, 10, 11, 13-15	8, 12	9	photometric (turbidity)
Bismuth	1-3, 5-10	4, 11-13		
Antimony	2, 4-8, 10, 12-14	1, 3, 9	11	photometric (crystal violet)
Cadmium	1-4, 8-12, 14	5-7, 13		
Phosphorus	1-4, 6, 7, 10, 13	-	5, 9	volumetric (alkalimetric)
			8, 11, 12	photometric (molybdenum yellow)
Sulfur	2, 4, 6	-	1, 3, 5, 7-10	combustion (infra-red detection)
Carbon	-	-	all	combustion (infra-red detection)
Copper	2, 6, 8	-	1, 3-5	electrogravimetric
			7, 9, 10	volumetric (thiosulfate)

## Notes

This Certified Reference Material has been produced and certified in accordance with the requirements of ISO Guide 34-2009, ISO Guide 31-2000 and ISO Guide 35-2006, taking into account the requirements of the ISO Guide to the Expression of Uncertainty in Measurement (GUM).

The unidirectional solidification effects associated with semi-chill casting have led to the formation of inhomogeneous segregates in the rear portion of the disc. The above certification is therefore only applicable from the front face of the disc to a depth of 12mm. Material to the rear of the disc, to a depth of ~3mm, is not certified.

This material will remain stable provided adequate precautions are taken to protect it from cross-contamination, extremes of temperature and atmospheric moisture. All production records will be retained for a period of 20 years from the date of this certificate. Technical support for this certification will therefore expire in May 2033, although we reserve the right to make changes as issue revisions, in the intervening period.

This material is also available in the form of chippings.

The manufacture, analysis and certification of this product were supervised by C Eveleigh, PhD, Technical Director, MBH Analytical Ltd.

The material to which this certificate of analysis refers is supplied subject to our general conditions of sale.